

| | | | | |
|-----------------------------------|---------------------------------------|--|--|-------------|
| Notice of References Cited | Application/Control No. 10/780,262 | | Applicant(s)/Patent Under Reexamination QIU ET AL. | |
| | Examiner JIANYE WU | | Art Unit 2462 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|---------------------|----------------|
| * | A | US-5,440,675 A | 08-1995 | Matsunaga et al. | 345/440 |
| * | B | US-2002/0018264 A1 | 02-2002 | Kodialam et al. | 359/128 |
| * | C | US-6,405,213 B1 | 06-2002 | Layson et al. | 707/104.1 |
| * | D | US-6,411,598 B1 | 06-2002 | McGlade, Bryan J. | 370/217 |
| * | E | US-2002/0101822 A1 | 08-2002 | Ayyagari et al. | 370/235 |
| * | F | US-6,771,966 B1 | 08-2004 | Chow, Peter El Kwan | 455/446 |
| * | G | US-2004/0250128 A1 | 12-2004 | Bush et al. | 713/201 |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) | | | |
|---|---|---|--|--|--|
| | U | | | | |
| | V | | | | |
| | W | | | | |
| | X | | | | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.